

## List of Tables

### Part A Fundamental Statistics and Its Applications

#### 1 Basic Statistical Concepts

Table 1.1	Results from a twelve-component life duration test.....	6
Table 1.2	Main rotor blade data .....	22
Table 1.3	Successive inter-failure times (in s) for a real-time command system .....	25
Table 1.4	Sample observations for each cell boundary .....	26
Table 1.5	Confidence limits for $\theta$ .....	29
Table 1.6	Cumulative areas under the standard normal distribution .....	43
Table 1.7	Percentage points for the $t$ -distribution ( $t_{\alpha,r}$ ).....	44
Table 1.8	Percentage points for the $F$ -distribution $F_{0.05, \nu_2/\nu_1}$ .....	45
Table 1.9	Percentage points for the $\chi^2$ distribution.....	46
Table 1.10	Critical values $d_{n,\alpha}$ for the Kolmogorov–Smirnov test .....	47

#### 2 Statistical Reliability with Applications

Table 2.1	Common lifetime distributions used in reliability data analysis.....	52
Table 2.2	Minimum cut sets and path sets for the systems in Fig. 2.3 .....	57

#### 3 Weibull Distributions and Their Applications

Table 3.1	Data set of failure test (data set 2) .....	74
Table 3.2	A sample of reliability applications.....	75
Table 3.3	A sample of other applications .....	76

#### 6 Prediction Intervals for Reliability Growth Models with Small Sample Sizes

Table 6.1	Values of the mean of the distribution of $R$ .....	118
Table 6.2	Values of the median of the distribution of $R$ .....	118
Table 6.3	Percentiles of the distribution of $R$ .....	119
Table 6.4	Predictions of fault detection times based on model .....	120
Table 6.5	Expected faults remaining undetected.....	120
Table 6.6	Probability of having detected all faults .....	121
Table 6.7	Observed ratios.....	121
Table 6.8	Prediction errors.....	122

#### 9 Modeling and Analyzing Yield, Burn-In and Reliability for Semiconductor Manufacturing: Overview

Table 9.1	Industry sales expectations for IC devices.....	154
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## Part B Process Monitoring and Improvement

### 11 Statistical Methods for Product and Process Improvement

Table 11.1	Noise factor levels for optimum combination .....	210
Table 11.2	Comparison of results from different methods .....	211

### 12 Robust Optimization in Quality Engineering

Table 12.1	$2^2$ factorial design for paper helicopter example .....	217
Table 12.2	Experiments along the path of steepest ascent .....	217
Table 12.3	Central composite design for paper helicopter example .....	217
Table 12.4	Comparison of performance responses using canonical and robust optimization approaches (true optimal performance: $-19.6$ ) .....	226
Table 12.5	Comparison of performance responses using canonical, robust, and weighted robust optimization .....	226

### 13 Uniform Design and Its Industrial Applications

Table 13.1	Experiment for the production yield $y$ .....	232
Table 13.2	ANOVA for a linear model .....	232
Table 13.3	ANOVA for a second-degree model .....	233
Table 13.4	ANOVA for a centered second-degree model .....	233
Table 13.5	The set up and the results of the accelerated stress test .....	233
Table 13.6	ANOVA for an inverse responsive model .....	234
Table 13.7	Experiment for the robot arm example .....	235
Table 13.8	A design in $\mathcal{U}(6; 3^2 \times 2)$ .....	237
Table 13.9	Construction of UD in $S_{a,b}^{3-1}$ .....	242

### 15 Chain Sampling

Table 15.1	ChSP-1 plans indexed by AQL and LQL ( $\alpha = 0.05$ , $\beta = 0.10$ ) for fraction nonconforming inspection .....	265
Table 15.2	Limits for deciding unsatisfactory variables plans .....	274

### 16 Some Statistical Models for the Monitoring of High-Quality Processes

Table 16.1	A set of defect count data .....	285
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### 17 Monitoring Process Variability Using EWMA

Table 17.1	Standard-deviation $\sigma(\tilde{Z})$ of the normal $(0, 1)$ sample median, for $n \in \{3, 5, \dots, 25\}$ .....	296
Table 17.2	Optimal couples $(\lambda^*, K^*)$ and optimal $ARL^*$ of the EWMA- $\bar{X}$ ( <i>half top</i> ) and EWMA- $\bar{X}$ ( <i>half bottom</i> ) control charts, for $\tau \in \{0.1, 0.2, \dots, 2\}$ , $n \in \{1, 3, 5, 7, 9\}$ and $ARL_0 = 370.4$ .....	297
Table 17.3	Constants $A_{S^2}(n)$ , $B_{S^2}(n)$ , $C_{S^2}(n)$ , $Y_0$ , $E(T_k)$ , $\sigma(T_k)$ , $\gamma_3(T_k)$ and $\gamma_4(T_k)$ for the EWMA- $S^2$ control chart, for $n \in \{3, \dots, 15\}$ .....	300
Table 17.4	Optimal couples $(\lambda^*, K^*)$ and optimal $ARL^*$ for the EWMA- $S^2$ control chart, for $\tau \in \{0.6, 0.7, 0.8, 0.9, 0.95, 1.05, 1.1, 1.2, \dots, 2\}$ , $n \in \{3, 5, 7, 9\}$ and $ARL_0 = 370.4$ .....	300

Table 17.5	Constants $A_S(n)$ , $B_S(n)$ , $C_S(n)$ , $Y_0$ , $E(T_k)$ , $\sigma(T_k)$ , $\gamma_3(T_k)$ and $\gamma_4(T_k)$ for the EWMA- $S$ control chart, for $n \in \{3, \dots, 15\}$ .....	304
Table 17.6	Optimal couples $(\lambda^*, K^*)$ and optimal $ARL^*$ for the EWMA- $S$ control chart, for $\tau \in \{0.6, 0.7, 0.8, 0.9, 0.95, 1.05, 1.1, 1.2, \dots, 2\}$ , $n \in \{3, 5, 7, 9\}$ and $ARL_0 = 370.4$ .....	306
Table 17.7	Expectation $E(R)$ , variance $V(R)$ and skewness coefficient $\gamma_3(R)$ of $R$ .....	307
Table 17.8	Constants $A_R(n)$ , $B_R(n)$ , $C_R(n)$ , $Y_0$ , $E(T_k)$ , $\sigma(T_k)$ , $\gamma_3(T_k)$ and $\gamma_4(T_k)$ for the EWMA- $R$ control chart, for $n \in \{3, \dots, 15\}$ .....	307
Table 17.9	Optimal couples $(\lambda^*, K^*)$ and optimal $ARL^*$ for the EWMA- $R$ control chart, for $\tau \in \{0.6, 0.7, 0.8, 0.9, 0.95, 1.05, 1.1, 1.2, \dots, 2\}$ , $n \in \{3, 5, 7, 9\}$ and $ARL_0 = 370.4$ .....	309
Table 17.10	Optimal out-of-control $ATS^*$ of the VSI EWMA- $S^2$ for $\tau \in \{0.6, 0.7, 0.8, 0.9, 0.95, 1.05, 1.1, 1.2, \dots, 2\}$ , $n \in \{3, 5\}$ , $h_5 \in \{0.1, 0.5\}$ , $W = \{0.1, 0.3, 0.6, 0.9\}$ , $ATS_0 = 370.4$ .....	311
Table 17.11	Optimal out-of-control $ATS^*$ of the VSI EWMA- $S^2$ for $\tau \in \{0.6, 0.7, 0.8, 0.9, 0.95, 1.05, 1.1, 1.2, \dots, 2\}$ , $n \in \{7, 9\}$ , $h_5 \in \{0.1, 0.5\}$ , $W = \{0.1, 0.3, 0.6, 0.9\}$ , $ATS_0 = 370.4$ .....	312
Table 17.12	Optimal $h_L^*$ values of the VSI EWMA- $S^2$ for $n \in \{3, 5, 7, 9\}$ , $\tau \in \{0.6, 0.7, 0.8, 0.9, 0.95, 1.05, 1.1, 1.2, \dots, 2\}$ , $h_5 \in \{0.1, 0.5\}$ , $W = \{0.1, 0.3, 0.6, 0.9\}$ , $ATS_0 = 370.4$ .....	313
Table 17.13	Optimal couples $(\lambda^*, K^*)$ of the VSI EWMA- $S^2$ for $n \in \{3, 5\}$ , $\tau \in \{0.6, 0.7, 0.8, 0.9, 0.95, 1.05, 1.1, 1.2, \dots, 2\}$ , $h_5 \in \{0.1, 0.5\}$ , $W = \{0.1, 0.3, 0.6, 0.9\}$ , $ATS_0 = 370.4$ .....	314
Table 17.14	Optimal couples $(\lambda^*, K^*)$ of the VSI EWMA- $S^2$ for $n \in \{7, 9\}$ , $\tau \in \{0.6, 0.7, 0.8, 0.9, 0.95, 1.05, 1.1, 1.2, \dots, 2\}$ , $h_5 \in \{0.1, 0.5\}$ , $W = \{0.1, 0.3, 0.6, 0.9\}$ , $ATS_0 = 370.4$ .....	315
Table 17.15	Subgroup number, sampling interval ( $h_5$ or $h_L$ ), total elapsed time from the start of the simulation and statistics $S_k^2$ , $T_k$ and $Y_k$ .....	317
Table 17.16	Optimal out-of-control $ATS^*$ of the VSI EWMA- $R$ for $\tau \in \{0.6, 0.7, 0.8, 0.9, 0.95, 1.05, 1.1, 1.2, \dots, 2\}$ , $n \in \{3, 5\}$ , $h_5 \in \{0.1, 0.5\}$ , $W = \{0.1, 0.3, 0.6, 0.9\}$ , $ATS_0 = 370.4$ .....	318
Table 17.17	Optimal out-of-control $ATS^*$ of the VSI EWMA- $R$ for $\tau \in \{0.6, 0.7, 0.8, 0.9, 0.95, 1.05, 1.1, 1.2, \dots, 2\}$ , $n \in \{7, 9\}$ , $h_5 \in \{0.1, 0.5\}$ , $W = \{0.1, 0.3, 0.6, 0.9\}$ , $ATS_0 = 370.4$ .....	319
Table 17.18	Optimal $h_L^*$ values of the VSI EWMA- $R$ for $n \in \{3, 5, 7, 9\}$ , $\tau \in \{0.6, 0.7, 0.8, 0.9, 0.95, 1.05, 1.1, 1.2, \dots, 2\}$ , $h_5 \in \{0.1, 0.5\}$ , $W = \{0.1, 0.3, 0.6, 0.9\}$ , $ATS_0 = 370.4$ .....	320
Table 17.19	Optimal couples $(\lambda^*, K^*)$ of the VSI EWMA- $R$ for $n \in \{3, 5\}$ , $\tau \in \{0.6, 0.7, 0.8, 0.9, 0.95, 1.05, 1.1, 1.2, \dots, 2\}$ , $h_5 \in \{0.1, 0.5\}$ , $W = \{0.1, 0.3, 0.6, 0.9\}$ , $ATS_0 = 370.4$ .....	321
Table 17.20	Optimal couples $(\lambda^*, K^*)$ of the VSI EWMA- $R$ for $n \in \{7, 9\}$ , $\tau \in \{0.6, 0.7, 0.8, 0.9, 0.95, 1.05, 1.1, 1.2, \dots, 2\}$ , $h_5 \in \{0.1, 0.5\}$ , $W = \{0.1, 0.3, 0.6, 0.9\}$ , $ATS_0 = 370.4$ .....	322

**18 Multivariate Statistical Process Control Schemes  
for Controlling a Mean**

Table 18.1	ARL comparison with bivariate normal data (uncorrelated) .....	337
Table 18.2	ARL comparison with bivariate normal data (correlated) .....	338
Table 18.3	Eigenvectors and eigenvalues from the 30 stable observations	340
Table 18.4	Probability of false alarms when the process is in control. Normal populations and X-bar chart .....	342
Table 18.5	The estimated ARL for Page's CUSUM when the process is in control. Normal populations .....	342
Table 18.6	The $h$ value to get in-control ARL $\approx 200$ , $k = 0.5$ . Page's CUSUM	342
Table 18.7	The estimate in-control ARL using Crosier's multivariate scheme .....	343

**Part C Reliability Models and Survival Analysis**

**19 Statistical Survival Analysis with Applications**

Table 19.1	Sample size per group based on the method of <i>Rubinstein</i> , et al. [19.18] $\alpha = 5\%$ , $\beta = 20\%$ .....	352
Table 19.2	Sample size per group based on the method of <i>Freedman</i> [19.22] (Weibull distribution with a shape parameter 1.5 assumed) $\alpha = 5\%$ , $\beta = 20\%$ .....	353
Table 19.3	Sample size per group based on (19.8); The lognormal case $\alpha = 5\%$ , $\beta = 20\%$ , $\sigma = 0.8$ .....	353
Table 19.4	Sample size per group based on (19.8); the Weibull case $\alpha = 5\%$ , $\beta = 20\%$ , $\sigma = 0.8$ .....	353
Table 19.5	Step-stress pattern after step 4 .....	360
Table 19.6	Count data .....	360
Table 19.7	Parameter estimates .....	360
Table 19.8	Percentiles of $S_3$ and $S_5$ .....	364

**21 Proportional Hazards Regression Models**

Table 21.1	Data table for the example .....	393
Table 21.2	Model fitting result .....	394

**22 Accelerated Life Test Models and Data Analysis**

Table 22.1	GAB insulation data .....	403
Table 22.2	GAB insulation data. Weibull ML estimates for each voltage stress .....	409
Table 22.3	GAB insulation data. ML estimates for the inverse power relationship Weibull regression model .....	409
Table 22.4	GAB insulation data. Quantiles ML estimates at 120 V/mm .....	412
Table 22.5	IC device data .....	412
Table 22.6	IC device data. Lognormal ML estimates for each temperature	414
Table 22.7	IC device data. ML estimates for the Arrhenius lognormal regression model .....	414

Table 22.8	Laminate panel data. ML estimates for the inverse power relationship lognormal regression model .....	415
Table 22.9	LED device subset data. ML estimates for the lognormal regression models (22.12) and (22.13) .....	417
Table 22.10	Spring fatigue data. ML estimates for the Weibull regression model .....	419
Table 22.11	Spring fatigue data. Quantiles ML estimates at (20 mil, 600 °F) for the Old and New processing methods .....	420
<b>23 Statistical Approaches to Planning of Accelerated Reliability Testing</b>		
Table 23.1	A summary of the characteristics of literature on optimal design of SSALT .....	432
<b>24 End-to-End (E2E) Testing and Evaluation of High-Assurance Systems</b>		
Table 24.1	Evolution of E2E T&E techniques .....	445
Table 24.2	Automatically generated code example .....	457
Table 24.3	Examples of obligation policies .....	461
Table 24.4	Examples of specifying system constraints .....	463
Table 24.5	Policy registration .....	464
Table 24.6	Reliability definition of ACDATE entities .....	467
Table 24.7	The most reliable services and their forecast .....	469
Table 24.8	ANOVA significance analysis .....	469
Table 24.9	Cooperative versus traditional ontology .....	472
<b>25 Statistical Models in Software Reliability and Operations Research</b>		
Table 25.1	Fitting of testing effort data .....	485
Table 25.2	Parameter estimation of the SRGM .....	485
Table 25.3	Estimation result on DS-3 .....	486
Table 25.4	Release-time problems .....	489
<b>26 An Experimental Study of Human Factors in Software Reliability Based on a Quality Engineering Approach</b>		
Table 26.1	Controllable factors in the design-review experiment .....	499
Table 26.3	Controllable factors in the design-review experiment .....	500
Table 26.2	Input and output tables for the two kinds of error .....	500
Table 26.4	The result of analysis of variance using the SNR .....	502
Table 26.5	The comparison of SNR and standard error rates .....	503
Table 26.6	The optimal and worst levels of design review .....	503
Table 26.7	The SNRs in the optimal levels for the selected inducers .....	503
Table 26.8	The comparison of SNRs and standard error rates between the optimal levels for the selected inducers .....	503
Table 26.9	The orthogonal array $L_{18}(2^1 \times 3^7)$ with assigned human factors and experimental data .....	504
Table 26.10	The result of analysis of variance (descriptive-design faults) ..	505

Table 26.11	The result of analysis of variance (symbolic–design faults) .....	505
Table 26.12	The result of analysis of variance by taking account of correlation among inside and outside factors .....	505
<b>27 Statistical Models for Predicting Reliability of Software Systems in Random Environments</b>		
Table 27.1	Summary of NHPP software reliability models .....	508
Table 27.2	Normalized cumulative failures and times during software testing .....	513
Table 27.3	Normalized cumulative failures and their times in operation .....	513
Table 27.4	MLE solutions for the $\gamma$ -RFE model .....	514
Table 27.5	MLE solutions for the $\beta$ -RFE model .....	514
Table 27.6	The mean–value functions for both RFEs models .....	515
Table 27.7	MLEs and fitness comparisons .....	518
<b>Part D Regression Methods and Data Mining</b>		
<b>28 Measures of Influence and Sensitivity in Linear Regression</b>		
Table 28.1	Three sets of data which differ in one observation .....	527
Table 28.2	Some statistics for the three regressions fitted to the data in Table 28.1 .....	527
Table 28.3	A simulated set of data .....	531
Table 28.4	Eigen–analysis of the influence matrix for the data from Table 28.3. The eigenvectors and eigenvalues are shown .....	531
Table 28.5	Values of the $t$ statistics for testing each point as an outlier ...	531
Table 28.6	Eigenvalues of the sensitivity matrix for the data from Table 28.3 .....	532
<b>29 Logistic Regression Tree Analysis</b>		
Table 29.1	Indicator variable coding for the species variable $S$ .....	539
Table 29.2	Predictor variables in the crash–test dataset. Angular variables $crbang$ , $pdof$ , and $impang$ are measured in degrees clockwise (from $-179$ to $180$ ) with $0$ being straight ahead .....	544
Table 29.3	Split at node 7 of the tree in Fig. 29.8 .....	546
Table 29.4	Split at node 9 of the tree in Fig. 29.8 .....	547
<b>30 Tree–Based Methods and Their Applications</b>		
Table 30.1	Electronic mail characteristics .....	552
Table 30.2	Seismic rehabilitation cost–estimator variables .....	553
Table 30.3	Characteristics of CPUs .....	559
Table 30.4	Comparison of tree–based algorithms .....	564
Table 30.5	Data–mining software for tree–based methods .....	565

<b>31 Image Registration and Unknown Coordinate Systems</b>	
Table 31.1 12 digitized locations on the left and right hand .....	573
Table 31.2 Calculation of residual lengths for data from Table 31.1 .....	583
<b>32 Statistical Genetics for Genomic Data Analysis</b>	
Table 32.1 Outcomes when testing $m$ hypotheses .....	593
Table 32.2 Classification results of the classification rules and the corresponding gene model.....	603
<b>33 Statistical Methodologies for Analyzing Genomic Data</b>	
Table 33.1 The numbers of genes belonging to the intersects of the five $k$ -means clusters and the 13 PMC clusters.....	614
<b>35 Radial Basis Functions for Data Mining</b>	
Table 35.1 Dataset for illustrative example .....	643
Table 35.2 Data description for the diabetes example.....	645
Table 35.3 RBF models for the diabetes example .....	646
Table 35.4 Selected models and error values for the diabetes example....	647
Table 35.5 Classification results for the cancer gene example .....	647
<b>Part E Modeling and Simulation Methods</b>	
<b>37 Bootstrap, Markov Chain and Estimating Function</b>	
Table 37.1 Minimum $L_q$ distance estimator ( $q = 1.5$ ). Simulated coverage probabilities and average confidence intervals (fixed design) .	683
<b>39 Cluster Randomized Trials: Design and Analysis</b>	
Table 39.1 Values for the mixed effects ANOVA model.....	708
Table 39.2 Changes in the variance components due to the inclusion of a covariate .....	713
Table 39.3 Assumptions about the intra-class correlation coefficient, with associated power with 86 groups and required number of groups for a power level of 0.9 .....	714
Table 39.4 Empirical type I error rate $\alpha$ and power $1 - \beta$ for the standard design and re-estimation design for three values of the prior $\rho$ . The true $\rho = 0.05$ .....	715
<b>40 A Two-Way Semilinear Model for Normalization and Analysis of Microarray Data</b>	
Table 40.1 Simulation results for model 1. $10\,000 \times$ Summary of MSE. The true normalization curve is the horizontal line at 0. The expression levels of up- and down-regulated genes are symmetric: $\alpha_1 = \alpha_2$ , where $\alpha_1 + \alpha_2 = \alpha$ .....	731
Table 40.2 Simulation results for model 2. $10\,000 \times$ Summary of MSE. The true normalization curve is the horizontal line at 0. But the percentages of up- and down-regulated genes are different: $\alpha_1 = 3\alpha_2$ , where $\alpha_1 + \alpha_2 = \alpha$ .....	731

Table 40.3	Simulation results for model 3. 10 000 × Summary of MSE. There are nonlinear and intensity-dependent dye biases. The expression levels of up- and down-regulated genes are symmetric: $\alpha_1 = \alpha_2$ , where $\alpha_1 + \alpha_2 = \alpha$ .....	731
Table 40.4	Simulation results for model 4. 10 000 × Summary of MSE. There are nonlinear and intensity-dependent dye biases. The percentages of up- and down-regulated genes are different: $\alpha_1 = 3\alpha_2$ , where $\alpha_1 + \alpha_2 = \alpha$ .....	731
<b>42 Genetic Algorithms and Their Applications</b>		
Table 42.1	Failure modes and probabilities in each subsystem .....	764
Table 42.2	Coordinates of Cooper and Rosing's example .....	770
Table 42.3	Comparison results of Cooper and Rosing's example .....	770
<b>44 Condition-Based Failure Prediction</b>		
Table 44.1	Mean values, standard deviations, and variances for different $T$ .....	803
<b>45 Statistical Maintenance Modeling for Complex Systems</b>		
Table 45.1	Optimal values $I$ and $L$ .....	824
Table 45.2	The effect of $L$ on $P_c$ for $I = 37.5$ .....	825
Table 45.3	Nelder-Mead algorithm results .....	830
Table 45.4	The effect of $(L_1, L_2)$ on $P_p$ for a given inspection sequence ...	830
Table 45.5	The effect of the inspection sequence on $P_p$ for fixed PM values .....	830
<b>46 Statistical Models on Maintenance</b>		
Table 46.1	Optimum $T^*$ , $N^*$ for $T = 1$ and percentile $T_p$ when $F(t) = 1 - \exp(-t/100)^2$ .....	839
Table 46.2	Optimum replacement number $K^*$ , failed element number $N^*$ , and the expected costs $C_1(K^*)$ and $C_2(N^*)$ .....	847
<b>Part F Applications in Engineering Statistics</b>		
<b>47 Risks and Assets Pricing</b>		
Table 47.1	Comparison of the log-normal and bi-log-normal model .....	890
<b>48 Statistical Management and Modeling for Demand of Spare Parts</b>		
Table 48.1	A summary of selected forecasting methods .....	907
Table 48.2	Classification of forecasting methods, corresponding testing ground and applications .....	909
Table 48.3	Summary of the better forecasting methods .....	911
Table 48.4	Comparison among some methods .....	913
Table 48.5	Ranking based on performance evaluation (MAD) .....	914
Table 48.6	Example of $N$ evaluation for a specific item (code 0X931: pin for fork gear levers) .....	918



Table 48.7	LS % and minimum cost related to $T_s d$ and $Rt/(C_m d)$ — no. of employments $n = 5$ .....	921
Table 48.8	LS % and minimum cost related to $T_s d$ and $Rt/(C_m d)$ — no. of employments $n = 15$ .....	921
Table 48.9	Optimization of $T_s$ for fixed number of spare parts $N$ .....	922

#### 49 Arithmetic and Geometric Processes

Table 49.1	Recommended estimators for $\mu_{A_1}$ and $\sigma_{A_1}^2$ .....	945
Table 49.2	Recommended estimators for $\mu_{G_1}$ and $\sigma_{G_1}^2$ .....	945
Table 49.3	Recommended estimators for $\mu_{\bar{A}_1}$ and $\sigma_{\bar{A}_1}^2$ , and $\mu_{\bar{G}_1}$ and $\sigma_{\bar{G}_1}^2$ ..	946
Table 49.4	Estimated values of common difference and ratio, and means for the 6LXB engine .....	950
Table 49.5	Estimated values of common difference and ratio, and means for the Benz gearbox .....	950
Table 49.6	Summary of useful results of both AP and GP processes .....	951

#### 50 Six Sigma

Table 50.1	Final yield for different sigma levels in multistage processes ..	958
Table 50.2	Number of Six Sigma black belts certified by the American Society for Quality (ASQ) internationally (ASQ record up to April, 2002) .....	959

#### 51 Multivariate Modeling with Copulas and Engineering Applications

Table 51.1	Some one-parameter ( $\alpha$ ) Archimedean copulas .....	980
Table 51.2	Comparison of $T^2$ percentiles when the true copula is normal and when the true copula is Clayton with various Kendall's $\tau$ . The percentiles under Clayton copulas are obtained from 100 000 simulations .....	984
Table 51.3	IFM fit for all the margins using normal and gamma distributions, both parameterized by mean and standard deviation. Presented results are log-likelihood (Loglik), estimated mean, and estimated standard deviation (StdDev) for each margin under each model .....	985
Table 51.4	IFM and CML fit for single-parameter normal copulas with dispersion structures: AR(1), exchangeable, and Toeplitz .....	986
Table 51.5	Maximum-likelihood results for the disk error-rate data. Parameter estimates, standard errors and log-likelihood are provided for both the multivariate normal model and the multivariate gamma model with a normal copula. The second entry of each cell is the corresponding standard error .....	986

#### 52 Queuing Theory Applications to Communication Systems: Control of Traffic Flows and Load Balancing

Table 52.1	Some heavy-tail distributions .....	1016
Table 52.2	Scheduling variables .....	1016
Table 52.3	DPRQ parameters .....	1018

Table 52.4   States of the DPRQ ..... 1019

**53   Support Vector Machines for Data Modeling with Software Engineering Applications**

Table 53.1   Data points for the illustrative example ..... 1028

Table 53.2   Three common inner-product kernels ..... 1030

Table 53.4   Classification results ..... 1034

Table 53.3   List of metrics from NASA database ..... 1034

Table 53.5   Performance of effort prediction models..... 1036

**54   Optimal System Design**

Table 54.1   Exhaustive search results ..... 1052

Table 54.2   Dynamic programming solution..... 1054

Table 54.3   Parameters for a series system ..... 1059

Table 54.4   Parameters for optimization of a series system ..... 1059

Table 54.5   Parameters for a hypothetical reliability block diagram ..... 1060

Table 54.6   Parameters for the optimization of a hypothetical reliability block diagram ..... 1060

Table 54.7   Parameters for a bridge network ..... 1062